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**National  
Institute of  
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Technology**

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- High Performance Systems and Services
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- Software Diagnostics and Conformance Testing

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<sup>1</sup>At Boulder, CO 80303.

<sup>2</sup>Some elements at Boulder, CO.

# *Journal of Research of the* **National Institute of Standards and Technology**

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# Contents

## Articles

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Uncertainty Analysis for Angle Calibrations Using Circle Closure	<b>W. Tyler Estler</b>	141
Chopped Radiation Measurements With Large Area Si Photodiodes	<b>George Eppeldauer</b>	153
An Easy-To-Use Combination Four-Terminal-Pair/ Two-Terminal-Pair AC Transformer Bridge	<b>A. Jeffery, J. Q. Shields, and L. H. Lee</b>	163
Can a Pressure Standard be Based on Capacitance Measurements?	<b>Michael R. Moldover</b>	167
Degradation of GaAs/AlGaAs Quantized Hall Resistors With Alloyed AuGe/Ni Contacts	<b>Kevin C. Lee</b>	177
Accurate Ab Initio Calculation of Molecular Constants	<b>S. Kotochigova and I. Tupitsyn</b>	201
Hyperfine Structure Constants for Diatomic Molecules	<b>I. Tupitsyn and S. Kotochigova</b>	205

---

## Conference Reports

---

Fourth International Symposium on Roofing Technology	<b>Walter J. Rossiter, Jr.</b>	209
International Workshop on Ultrasonic and Dielectric Characterization Techniques for Suspended Particulates	<b>Vincent A. Hackley and John Texter</b>	217
NIST Meeting on Multicomponent Polymers and Polyelectrolytes	<b>Jack Douglas</b>	225

---

## News Briefs

---

<b>GENERAL DEVELOPMENTS</b>	227
New Imaging Technique Strong on Power, Gentle on Samples Failure of Tiny Rivets May Have Sunk “Unsinkable” Liner	
Largest Ever Expansion of Mass Spectral Database Available NIST Helps Shuttle Fly Free of Flaws in Flow Measurement POSIX Testing Program a Success	228
Time Synchronization for Distributed Computing MOIST 3.0 Completed and Released Two Accreditation Bodies Recognized	229

New Approach Developed in Fabrication of Magnetic Nanowire Arrays NIST to Develop Laser-Cooled Clock for the International Space Station Simple Multiwavelength Cross Correlator Used for Ultrashort Pulse	230
NIST-Led Beam Profile Round-Robin Completed ALOFT-FT™ Developed for Personal Computers	231
NIST Staff Clarify Mechanism of Super Flame Suppressant Technique Developed to Measure Effects of Tribochemistry on Film Strength Homogeneous Materials Prepared by Rapid Solidification for Standard Reference Material Applications	232
International Comparison of Charpy Impact Reference Machines and Specimens NIST TBT Agreement Activities Report Published Energy-Related Inventions Program Makes Recommendations Model Developed for Diamond Turning Process	233
Method Developed for Electrochemical Quantitation of Surface-Immobilized DNA Structure and Hybridization of Surface-Tethered DNA Observed With Neutron Reflectivity	234
Optical Wedge Effects in Instruments and Standards for Molecular Absorption Spectrophotometry Workshop on Development of Standards for Concrete and Masonry Structures Conducted by NIST United States/Canada Interlaboratory Comparison Completed	235
Collaboration between NIST and Private Company Demonstrates Capability of Ion Implantation Dose Measurements NIST Hosts ASTM Workshop on Standards for Tissue-Engineered Medical Products Fast Spherical Filter Gets Diverse Application	236
Study Scopes Service Sector Tech Trends, Needs NIST Short Course Yields Better Temperature Measures EMAT Applied to Magnetostriction of Metals	237
NIST and Private Company Extend CRADA on Gallium Nitride Films Partners Fill Big Need With Better SRMs for Shrinking Chips Seven Trapped Ions Make a Better Clock Comments on Softwood Lumber Standard Sought	238
NIST Lab Upgrades Scientific Data on the Web Partners Create New Detector for Fiber Power Measurements Tensile Testing of Thin Films Showcased in Reference Set	239
NIST Adds Three Cryptographic Modules to the FIPS 140-1 Validated Products List New Measurement Techniques Will Improve Sheet Metal Forming NIST Developed a Pressure Drop Model to Help the Air-Conditioning Industry	240
NIST Rockwell Hardness Indenter to be used as an International Common Indenter Novel Spectroscopy of a Biomolecule at a Surface Observed at SURF	241
New Facility Commissioned to Investigate Heat Transfer Phenomena in Supercritical Fluids New Radiation Dose Calibration Service Modification of Laser-Produced Nanostructures	242
Recharacterization of the NIST Thermal Transfer Standards Carried Out for CCE Intercomparisons Charge Noise Identified as Barrier to SET Device Operation	243

Intelligent Manufacturing Systems (IMS) MISSION Consortium Formed NIST and Industry Work Together to Develop a Protection Profile for Role Based Access Control (RBAC) NIST and Industry Collaborate on Interoperability Testing Rapid Thermal Processing Advisory Group Meets at NIST	244
NIST and the U.S. Air Force Explore New Fire Suppression Technology for Aircraft Post-Earthquake Fires and Lifelines Improved Variable-Air-Volume Air-Handling Unit Control Joint Army/NIST Research on Neutron Probes for Sapphire Windows	245
Precision Engineering Division Staff Represent NIST at ISO Technical Committee 213 Use of New Cryogenic Current Comparator Bridge Improves Resistance Calibration Service Active AC Voltage Divider Extends Range for Primary Electric Power Calibrations	246
NIST Advances Speech Recognition Technology NIST Researcher Completes Work on Information Model Crucial to International Standard	247
Industry and Government Benefit From Published Specifications for Validation of Implementations of Data Encryption Standard (DES) or Skipjack Algorithms OpenGL Adopts NIST Fortran 90 Binding NIST Hosts CAM-I Members at Workshop Focused on Establishing Collaborative Projects	248
Tool Stability Increased In High-Speed Milling New Techniques for Measuring Electron Densities in Plasmas Photon Cross Section Database Now Available On-Line	249
Nonlinear Dynamics of Intense Femtosecond Pulse Propagation SP 250 Series for Radiometric Measurements Updated Sodium Bose-Einstein Condensation Produced	250
Development of Standard Test Method to Assess Grinding Damage in Ceramic Materials Initiated New System for Nanoscale Multilayer Deposition Allows Control of Thickness and Layer Sequence Energy-Related Inventions Program Makes Recommendations	251
NIST Hosts Radar Cross Section Measurement Certification Meeting NIST Works With Industry to Apply Usability Testing Results in the Procurement of Software NIST and Private Company Co-Sponsor North American ISDN Users' Forum (NIUF)	252
Workshop on Standards for Nucleic Acid Diagnostic Applications NIST Hosts ISO and OIML Meetings on Water Meter Standards Standards Information Seminar Hosted at NIST	253
International Collaboration on Data Exchange Standards for the Process Industries	254
<b>STANDARD REFERENCE MATERIALS</b> SRM Available for Optical Fiber Metrology NIST Produces First Standard Reference Material for the Fluid Power Industry	<b>254</b>
<b><i>Calendar</i></b>	<b>257</b>

---